



TEST REPORT

On Behalf of

Shenzhen QIJIE Electronic CO., LTD

2F Building 21th, Chuangye RD, Shilongzai Industrial Park Shiyan, Baoan District, Shenzhen, GD, China

LED Strip Connector

Model:Hippo-M SDP

Test Standard:	EN 60695-11-5:2017

Report Number : GVTS250514104

- **Test Date** : May. 19 - May. 26, 2025
- **Date of Report** : May. 28, 2025
- **Prepared By** : ShenZhen GVT Testing Technology Co., Ltd. Room 504, Unit 1, Building 4, Zhaofuda Industrial Zone, Hongqiaotou Community, Yanluo Street, Bao 'an District, Shenzhen, Guangdong, China.

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TEST REPORT EN 60695-11-5:2017			
	art 11-5: Test flames - Needle-flame test method - Apparatus, nfirmatory test arrangement and guidance		
Report reference No	GVTS250514104		
Date of issue	May. 28, 2025		
Testing laboratory			
Testing Laboratory Name :	ShenZhen GVT Testing Technology Co., Ltd.		
	Room 504, Unit 1, Building 4, Zhaofuda Industrial Zone, Hongqiaotou Community, Yanluo Street, Bao 'an District, Shenzhen, Guangdong, China.		
Test location	(Same as above)		
Client			
Name	Shenzhen QIJIE Electronic CO., LTD		
Address	2F Building 21th, Chuangye RD, Shilongzai Industrial Park Shiyan, Baoan District, Shenzhen, GD, China		
Test specification			
Standard	EN 60695-11-5:2017		
Test procedure :	Safety report		
Procedure deviation :	N.A.		
Non-standard test method :	N.A.		
Test Report Form No	IEC 60695-11_1E		
rRF originator	:: UL(US)		
Master TRF	Dated 2022-04-14		
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۲his report is not valid as a C	B Test Report unless signed by an approved CB Testing Laboratory and cate issued by an NCB in accordance with IECEE 02.		
Test item			
Description			
Model No	Hippo-M SDP		
Other models :	N/A		
Trade Mark	N/A		
Manufacturer	Shenzhen QIJIE Electronic CO., LTD		
Address	2F Building 21th, Chuangye RD, Shilongzai Industrial Park Shiyan, Baoan District, Shenzhen, GD, China		
Models difference	N/A		

Possible test case verdicts:	6 6 6 6 6 6 6 6 6 6 6 6			
- test case does not apply to the test object		N(N/A)		
- test object does meet the requirement		P(Pass)		
- test object does not meet the requirement		F(Fail)		
Testing		i		
Date of receipt of test item		:	May. 14, 2025	
Date (s) of performance of tes	ts	:	May. 19 - May. 26, 2025	
Sample appearance and funct condition, yes or no	ion 	are in normal	Yes	
Ambient temperature	•••••	·······	[김 김 옷 옷 옷 김 옷 옷 옷 옷 옷 옷 옷 옷 옷 옷 옷 옷 옷	
Ambient humidity	<u></u>	i	54%	
General remarks:				
The test results presented in the	nis r	eport relate only to th	e object tested.	
This report shall not be reprod	uce	d, except in full, witho	out the written appro	oval of the Issuing testing laboratory.
Laboratory GVT. The authenti for this Test Report.	city	of this Test Report ar	nd its contents can	be verified by contacting GVT, responsible
"(see Enclosure #)" refers to a	addi	tional information app	pended to the repo	ort.
"(see appended table)" refers		~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~	~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~ ~	
Throughout this report a 🗌 c	omr	na / 🛛 point is used	as the decimal sep	parator.
Summary of testing:				
The submitted sample were to	este	d and found to compl	iance with requiren	nents of the standards
EN 60695-11-5:2017	8 8 8 8		- 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5 5	
Testing procedure and testing location				
Laboratory name		ShenZhen GVT Tes	sting Technology C	co., Ltd.
Testing location/address				la Industrial Zone, Hongqiaotou strict, Shenzhen, Guangdong, China.
Testing procedure		TL 🛛 RMT 🗌		
Tested By (Test Engineer)		Keith Zhu		Kerth Zhm. Clare Wen
Reviewed By (Supervisor)		Clare Wen		clare Wen
Approved By (Chief Engineer)		Peter Chen	-	GVT TOPROVED

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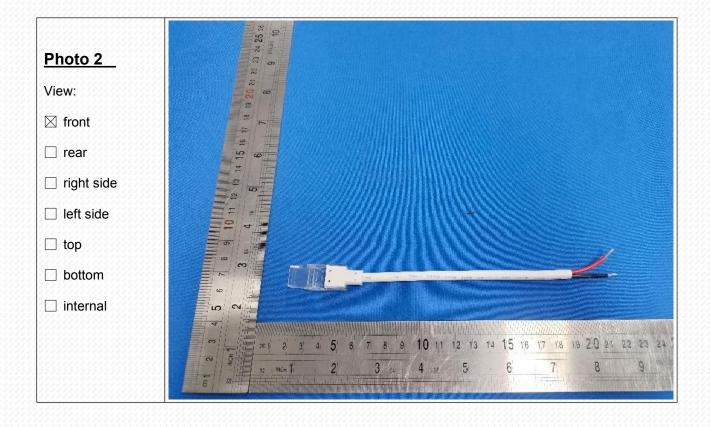
EN 60695-11-5:2017					
Section	Requirement + Test	Result - Remark	Verdict		

Needle-flame test	Test conditions: The surface tested and point of application of the needle-flame: Center point Test time: 30 s Requirements: A) There is no ignition of the specified layer and, after the removal of the needle-flame, there is no flame and no glowing of the test specimen. B) Flames or glowing of the test specimen and the surrounding parts extinguish within 30 s after the removal of the needle-flame, that is $t_b < 30$ s. Also, the surrounding parts have not burnt away completely and there has been no ignition of the specified layer.	The sample has no burning; the surrounding parts have not burnt away completely and there has been no ignition	P
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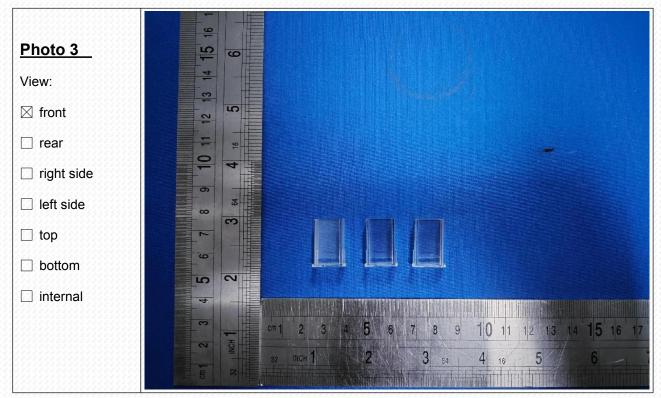
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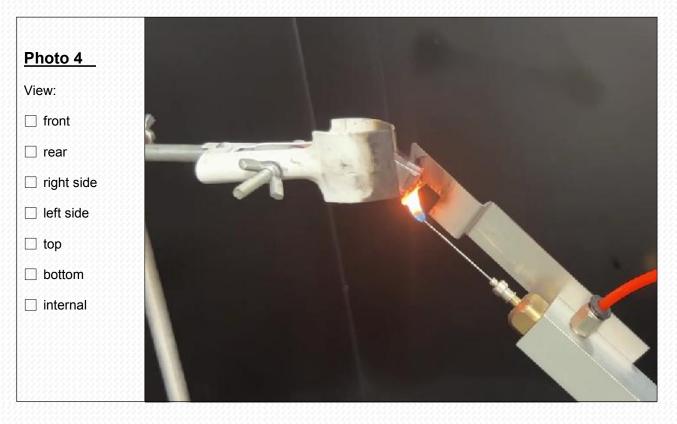
Photo Documentation





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End of Report